Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/016,242	YOKONO ET AL.	
Examiner	Art Unit	-
Philip B. Tran	2155	

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Class	Subclass	Date	Examiner
Updated	Search	6/23/2006	РВТ
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner

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